## Notice of References Cited Application/Control No. O9/470,234 Examiner Hae M. Hyeon Applicant(s)/Patent Under Reexamination SALGADO ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,224,485	09-1980	Krumreich, Charles L.	200/51.1
*	В	US-4,699,443	10-1987	Goodrich et al.	439/188
*	c.	US-5,599,209 A	02-1997	Belopolsky, Yakov	439/676
*	D	US-6,056,568 A	05-2000	Arnett, Jaime Ray	439/188
*	Е	US-6,350,148 B1	02-2002	Bartolutti et al.	439/489
*	F	US-6,497,588 B1	12-2002	Scharf et al.	439/607
*	G	US-6,499,861 B1	12-2002	German et al.	362/253
*	н	US-6,885,478 B1	04-2005	Salgado et al.	358/449
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s			•		
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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